

**ATTORNEY DOCKET NO.**  
**13631.0007**

**PATENT**  
**Customer ID No. 33649**

**Amendments to the Claims:**

This listing of claims will replace all prior versions, and listings, of claims in the application:

1. **(Currently amended)** A system for inspecting components comprising:  
a CMOS imaging system generating image data;  
an image analysis system coupled to the CMOS imaging device, the image analysis system receiving the image data and generating image analysis data;  
a processor coupled to the image analysis system, the processor operating one or more additional software systems used for image data analysis, wherein the processor, the image analysis system, and the CMOS imaging system are an embedded imaging system;  
and  
wherein the CMOS imaging system generates the image data at a rate that allows the CMOS imaging device to be used for inspecting components in response to line shift control data received from the image analysis system.
2. **(ORIGINAL)** The system of claim 1 wherein the CMOS imaging system further comprises a CMOS active pixel sensor.
3. **(ORIGINAL)** The system of claim 2 wherein the CMOS active pixel sensor is a Photobit model PB 1024 CMOS active pixel sensor.

Claim 4 (cancelled).

5. **(ORIGINAL)** The system of claim 1 wherein the CMOS imaging system further comprises an image analysis controller receiving pixel data from a sensor and generating the image data from the pixel data.

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6. (ORIGINAL) The system of claim 1 wherein the CMOS imaging sensor generates lines of image data at a speed greater than one line every 15.6 microseconds.
7. (ORIGINAL) The system of claim 1 wherein the CMOS imaging sensor generates frames of image data at a rate greater than one frame every 30 milliseconds.
8. (ORIGINAL) The system of claim 1 wherein the CMOS imaging sensor further comprises a pixel shift system that enables a readout sequence to start at a pixel series position that reduces noise and improves signal quality
9. (ORIGINAL) The system of claim 8 wherein the pixel shift system enables the readout sequence to start at a fifth pixel series position.

Claims 10 through 12 (cancelled).

13. (Currently Amended) A method for generating image data of a component for use in inspecting the component comprising:

generating pixel data using a CMOS imaging system;  
transferring the pixel data as a plurality of pixel lines, further comprising  
generating a reset command;  
initiating a pixel line at the next clock cycle after the reset command;  
waiting a predetermined number of clock cycles to generate a next pixel line;  
and  
wherein the predetermined number of clock cycles is less than 208 clock  
cycles;  
assembling the pixel lines into a frame; and  
wherein the frame is assembled in less than 30 milliseconds.

14. (ORIGINAL) The method of claim 13 wherein generating pixel data using a CMOS imaging system further comprises generating pixel data using a CMOS active pixel sensor.

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15. **(ORIGINAL)** The method of claim 13 wherein generating pixel data using a CMOS imaging system further comprises generating pixel data using a Photobit model PB 1024 CMOS active pixel sensor.

Claim 16 (cancelled).

17. **(ORIGINAL)** The method of claim 13 wherein transferring the pixel data as the plurality of pixel lines further comprises initiating a read sequence for each of the pixel lines at a predetermined pixel series position.

18. **(ORIGINAL)** The method of claim 13 wherein transferring the pixel data as the plurality of pixel lines further comprises initiating a read sequence for each of the pixel lines at a fourth pixel series position.

19. **(ORIGINAL)** The method of claim 13 wherein assembling the pixel lines into the frame further comprises reading a first frame following the generation of a reset command.

20. **(ORIGINAL)** The method of claim 13 wherein the frame is assembled in 13.5 milliseconds.